TOSHIBA 2SK1827

#### TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

# 2 S K 1 8 2 7

#### HIGH SPEED SWITCHING APPLICATIONS

### **ANALOG SWITCH APPLICATIONS**

4V Gate Drive

Low Threshold Voltage:  $V_{th} = 0.8 \sim 2.5 V$ 

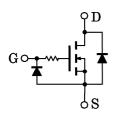
High Speed

Enhanncement-Mode

Small Package

**EOUIVALENT CIRCUIT** 

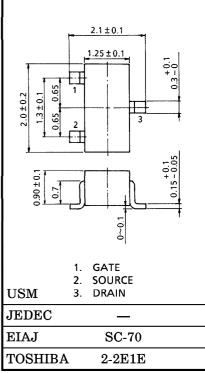
**MARKING** 





This transistor is electrostatic sensitive device. Please handle with caution.

#### Unit in mm



Weight: 0.006g (Typ.)

## MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	$v_{ m DS}$	50	V
Gate-Source Voltage	$v_{GSS}$	10	V
DC Drain Current	$I_{\mathbf{D}}$	50	mA
Drain Power Dissipation	$P_{\mathbf{D}}$	100	mW
Channel Temperature	$\mathrm{T_{ch}}$	150	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	$^{\circ}\mathrm{C}$

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# ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{ ext{GSS}}$	$V_{GS}=10V, V_{DS}=0$	_	_	1	$\mu$ A
Drain-Source Breakdown Voltage		V <sub>(BR)</sub> DSS	$I_{D} = 100 \mu A, V_{GS} = 0$	50	_	_	V
Drain Cut-off	Current	$I_{ m DSS}$	$V_{DS}=50V, V_{GS}=0$	_	_	1	$\mu$ A
Gate Threshole	d Voltage	$v_{th}$	$V_{\mathrm{DS}} = 5 \mathrm{V}, \; \mathrm{I_D} = 0.1 \mathrm{mA}$	0.8		2.5	V
Forward Transfer Admittance		$ Y_{fs} $	$V_{\mathrm{DS}}$ =5V, $I_{\mathrm{D}}$ =10mA	20	_	_	mS
Drain-Source ON Resistance		R <sub>DS</sub> (ON)	$I_D=10$ mA, $V_{GS}=4.0$ V	_	20	50	Ω
Input Capacitance		$\mathrm{c}_{\mathrm{iss}}$	$V_{DS}=5V$ , $V_{GS}=0$ , $f=1MHz$	_	6.3	_	рF
Reverse Transfer Capacitance		$C_{ extbf{rss}}$	$V_{\mathrm{DS}}$ =5V, $V_{\mathrm{GS}}$ =0, f=1MHz	_	1.3	_	pF
Output Capacitance		$C_{oss}$	$V_{DS}=5V$ , $V_{GS}=0$ , $f=1MHz$	_	5.7	_	pF
Switching Time	Turn-on Time	$t_{on}$	V <sub>DD</sub> =5V, I <sub>D</sub> =10mA, V <sub>GS</sub> =0~4.0V	_	0.11	_	$\mu$ s
	Turn-off Time	$t_{ m off}$	V <sub>DD</sub> =5V, I <sub>D</sub> =10mA, V <sub>GS</sub> =0~4.0V	_	0.15	_	μs

## SWITCHING TIME TEST CIRCUIT

